

1F., Block A of Tongsheng Technology Building, Huahui Road, Dalang Street, Longhua District, Shenzhen, China

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Telephone: +86-755-26648640 Fax: +86-755-26648637

Website: <u>www.cqa-cert.com</u>

# **RF Exposure Evaluation Report**

**Report No.:** CQASZ20190600441E-02

Applicant: Kool Brands, LLC.

Address of Applicant: P.O. box 41270 Reno, NV 89504

Manufacturer: LITE STAR ELECTRONICS TECHNOLOGY Co.,Ltd.

Address of Xingchen Science park Lianbi Road, Wulian Industry Area, Fenggang Town,

Manufacturer: Dongguan City, China

#### **Equipment Under Test (EUT):**

**Product:** SEGA Genesis, Megadrive Bluetooth Control Pad All Model No.: RET00143, RET00142, RB-SGA-012, RB-SGA-011

Test Model No.: RB-SGA-011

Brand Name: Retro-Bit

FCC ID: 2ARPV-G011TR
Standards: 47 CFR Part 1.1307

47 CFR Part 2.1093

KDB447498D01 General RF Exposure Guidance v06

**Date of Test:** 2019-06-06 to 2019-06-12

**Date of Issue:** 2019-06-12

Test Result : PASS\*

Tested By:

Reviewed By:

Approved By:

(Daisy Qin)

(Aaron Ma )



The test report is effective only with both signature and specialized stamp, The result(s) shown in this report refer only to the sample(s) tested. Without written approval of CQA, this report can't be reproduced except in full.

<sup>\*</sup> In the configuration tested, the EUT complied with the standards specified above.



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# 1 Version

# **Revision History Of Report**

Report No.	Version	Description	Issue Date
CQASZ20190600441E- 02	Rev.01	Initial report	2019-06-12





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## 3 General Information

## 3.1 Client Information

Applicant:	Kool Brands, LLC.
Address of Applicant:	P.O. box 41270 Reno, NV 89504
Manufacturer:	LITE STAR ELECTRONICS TECHNOLOGY Co.,Ltd.
Address of Manufacturer:	Xingchen Science park Lianbi Road, Wulian Industry Area, Fenggang Town, Dongguan City, China

## 3.2 General Description of EUT

Product Name:	SEGA Genesis, Megadrive Bluetooth Control Pad			
All Model No.:	RET00143, RET00142, RB-SGA-012, RB-SGA-011			
Test Model No.:	RB-SGA-011			
Trade Mark:	Retro-Bit			
Hardware Version:	VER:08			
Software Version:	REV:A1			
Operation Frequency:	2402MHz~2480MHz			
Bluetooth Version:	V4.0			
Modulation Technique:	Frequency Hopping Spread Spectrum(FHSS)			
Modulation Type:	GFSK, π/4DQPSK, 8DPSK			
Transfer Rate:	1Mbps/2Mbps/3Mbps			
Number of Channel:	79			
Hopping Channel Type:	Adaptive Frequency Hopping systems			
Product Type:	☐ Mobile ☐ Portable ☐ Fix Location			
Test Software of EUT:	RDA Host Contorller Tester – HCDT1 (manufacturer declare )			
Antenna Type:	PCB antenna			
Antenna Gain:	-1.42dBi			
Power Supply:	lithium battery:DC3.7V, Charge by DC5V			

#### Note:

- 1. The same product has two names.
- 2. All model: RET00143, RET00142, RB-SGA-012, RB-SGA-011

Only the model RB-SGA-011 was tested, since the electrical circuit design, layout, components used and internal wiring were identical for the above models, with difference being color of appearance and model name.



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## 4 SAR Evaluation

## 4.1 RF Exposure Compliance Requirement

#### 4.1.1 Standard Requirement

According to KDB447498D01 General RF Exposure Guidance v06

4.3.1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

#### **4.1.2 Limits**

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)]  $\sqrt{f(GHz)} \le 3.0$  for 1-g SAR and  $\le 7.5$  for 10-g extremity SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation<sup>17</sup>

The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is  $\leq$  50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is  $\leq$  5 mm, a distance of 5 mm is applied to determine SAR test exclusion





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## 4.1.3 EUT RF Exposure

#### **Measurement Data**

Measurement Data					
	GFSK	mode			
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
	(dBm)	(dBm)	(dBm)	(mW)	
Lowest(2402MHz)	3.910	4±1	5	3.162	
Middle(2441MHz)	4.290	4±1	5	3.162	
Highest(2480MHz)	4.490	4±1	5	3.162	
π/4DQPSK mode					
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
	(dBm)	(dBm)	(dBm)	(mW)	
Lowest(2402MHz)	4.710	5±1	6	3.981	
Middle(2441MHz)	5.070	5±1	6	3.981	
Highest(2480MHz)	5.330	5±1	6	3.981	
	π/4DQPS	SK mode			
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
	(dBm)	(dBm)	(dBm)	(mW)	
Lowest(2402MHz)	5.130	5±1 6		3.981	
Middle(2441MHz)	5.600	5±1	6	3.981	
Highest(2480MHz)	5.820	5±1	6 3.981		

Worst case: GFSK						
Channel	Maximum Peak Conducted Output Power (dBm)  Tune up tolerance (dBm)	Maximum tune- up Power		Calculated	Exclusion	
		(dBm)	(mW)	value	threshold	
Lowest (2402MHz)	5.130	5±1	6	3.981	1.23	
Middle (2441MHz)	5.600	5±1	6	3.981	1.24	3.0
Highest (2480MHz)	5.820	5±1	6	3.981	1.25	
Conclusion: the calculated value ≤3.0, SAR is exempted.						

Remark: The Max Conducted Peak Output Power data refer to report Report No.: CQASZ20190600441E-01